

**Search Notes**

Application/Control No.

10/064,881

Examiner

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Applicant(s)/Patent under  
Reexamination

CHANG, YI-CHEN

Art Unit

2674

**SEARCHED**

Class	Subclass	Date	Examiner
345	76-83	6/20/2005	AE
345	87-102		
345	60-72		
above	updated	11/23/2005	AE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, USPGPUB, USPAT, EPO, JPO, inventor/assignee search	6/20/2005	AE